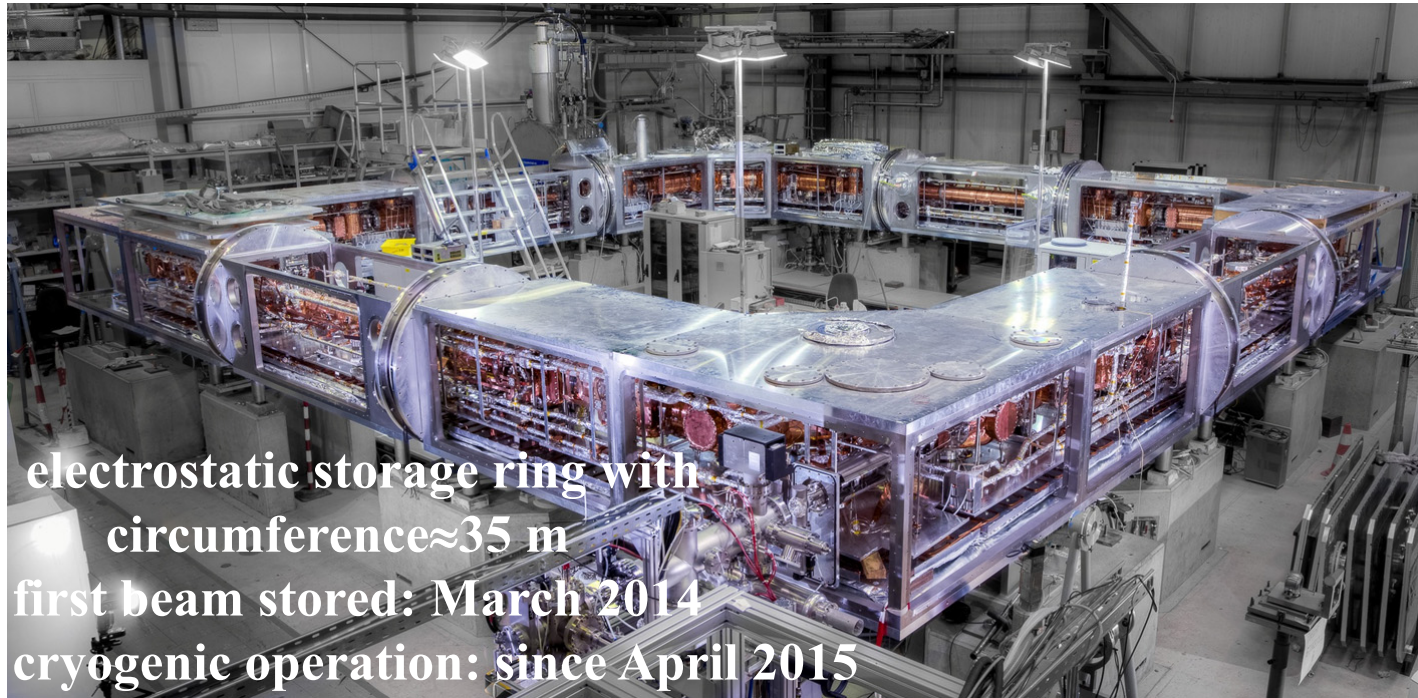


The Cryogenic Storage Ring CSR



Manfred Grieser

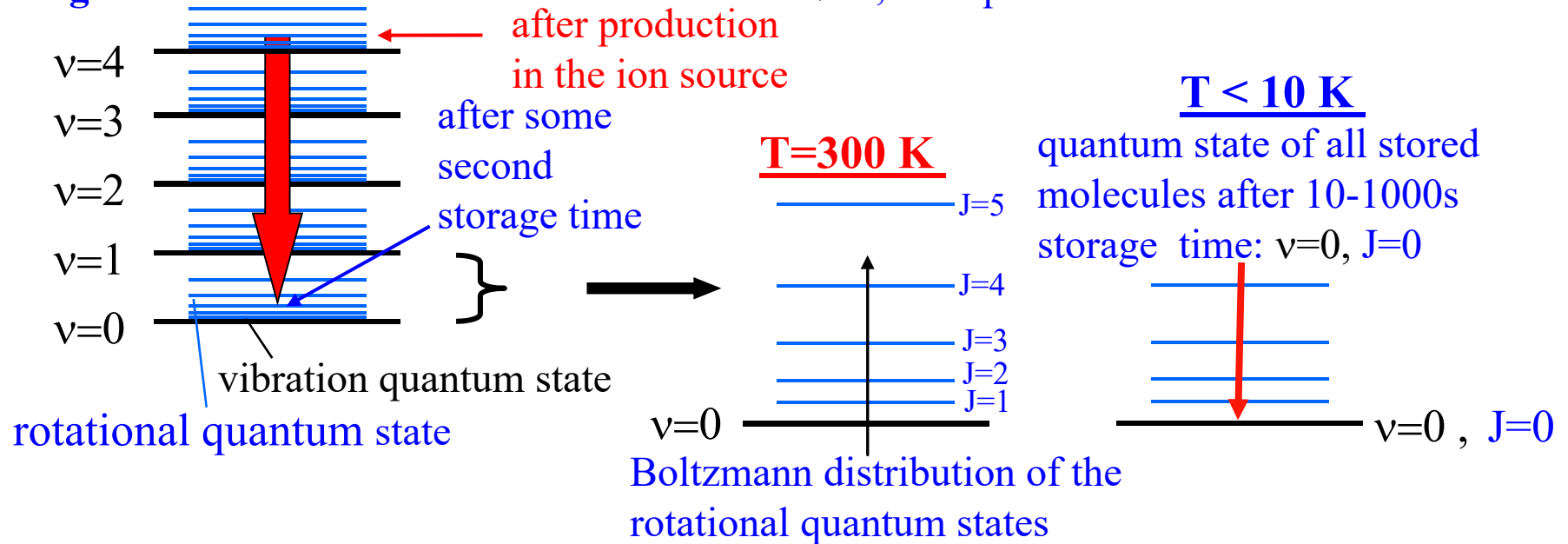
Max Planck Institute for Nuclear Physics

HIAT2015 , September 8, 2015

Purpose of the CSR

main research field: molecular ion physics

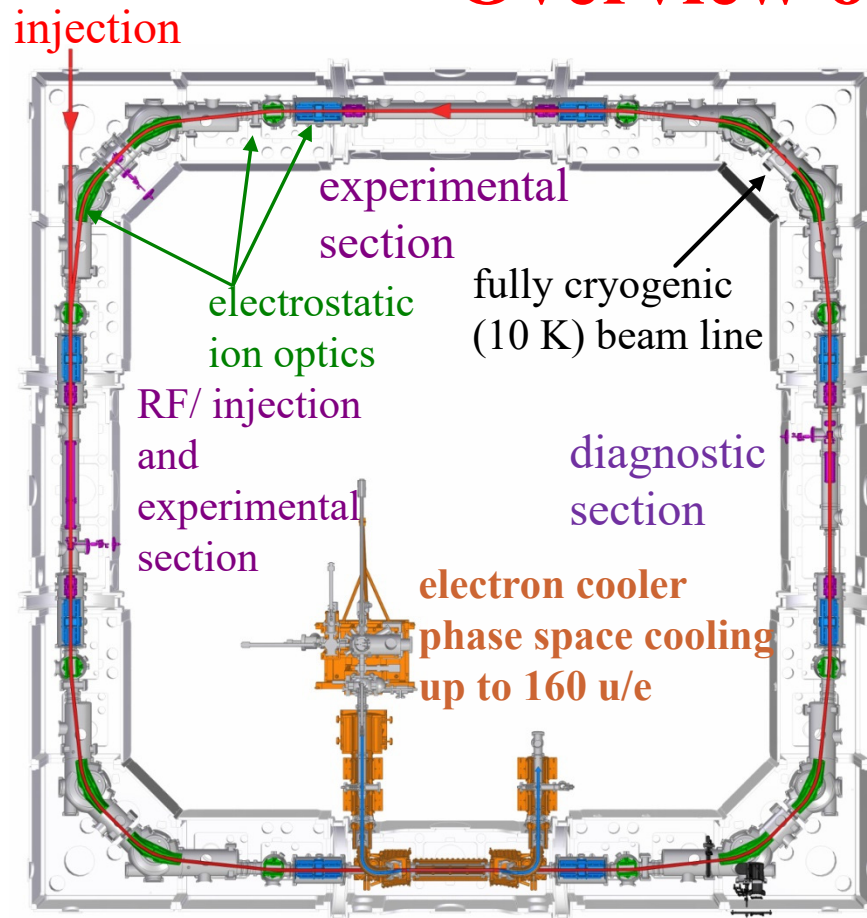
goal: all molecular ions to have in the same $v=0$, $J=0$ quantum state



to get all molecular ions in the same molecular quantum state ($v=0$, $J=0$) the molecular ions have to be stored at $T < 10\text{ K}$

$\Rightarrow$ a new Cryogenic Storage Ring (CSR) at MPIK Heidelberg
in opposite to other storage rings it is an **electrostatic storage ring**

Overview of the CSR



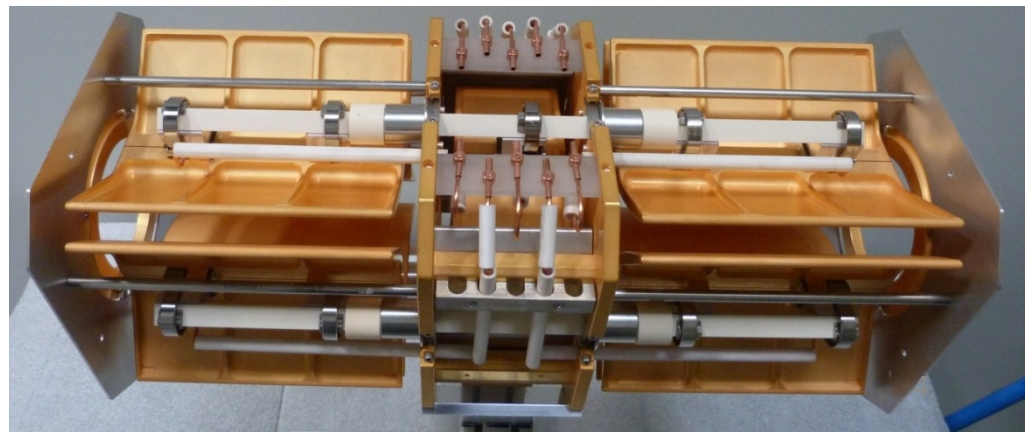
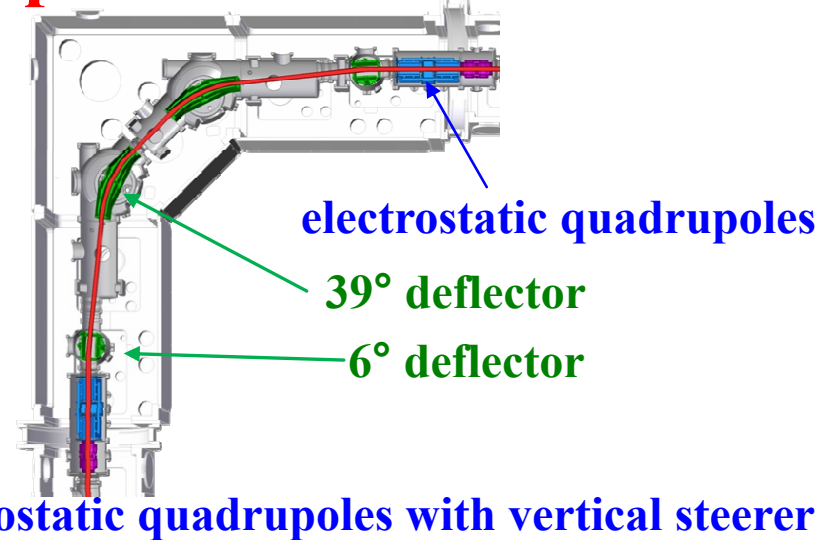
circumference: ≈ 35 m
beam energy: $(20-300) \cdot q$ keV
temperature: 10-300 K
residual gas densities:
 (at $T < 10$ K): < 20 molecules/cm³

with electron cooling
m/q range: 1 -160
 (at $E/Q = 300$ kV)
lowest rigidity: p^+ , H^- at $E/Q = 20$ kV
 $B\rho = 0.02$ Tm

Electrostatic beam optics Elements

- 4-fold symmetric storage ring
all CSR corner sections identical
- 4 x 2 pairs of **quadrupoles** (± 10 kV, $\varnothing = 100$ mm)
- 4 x 2 **6°-deflector** electrodes (± 30 kV, $d = 120$ mm)
- 4 x 2 **39°-deflector** electrodes (± 30 kV, $d = 60$ mm)
- 4 long free straight sections (≈ 2.8 m each)

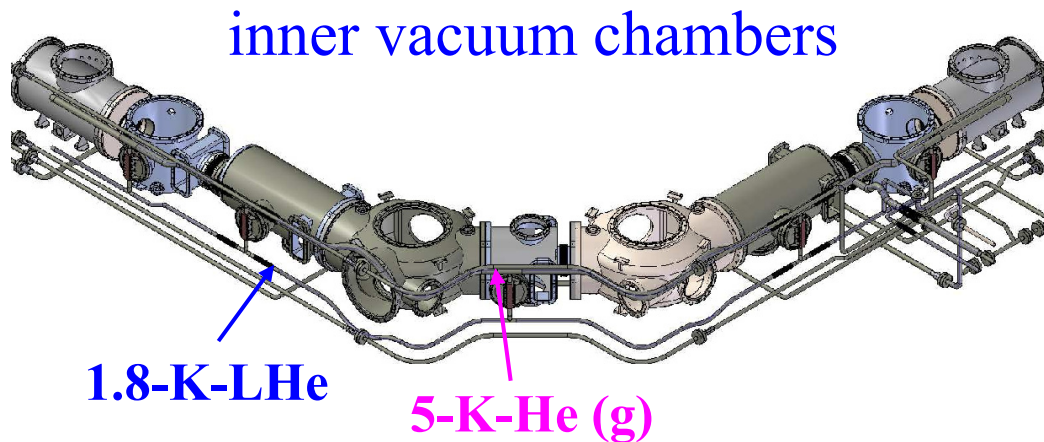
39° cylindrical deflector



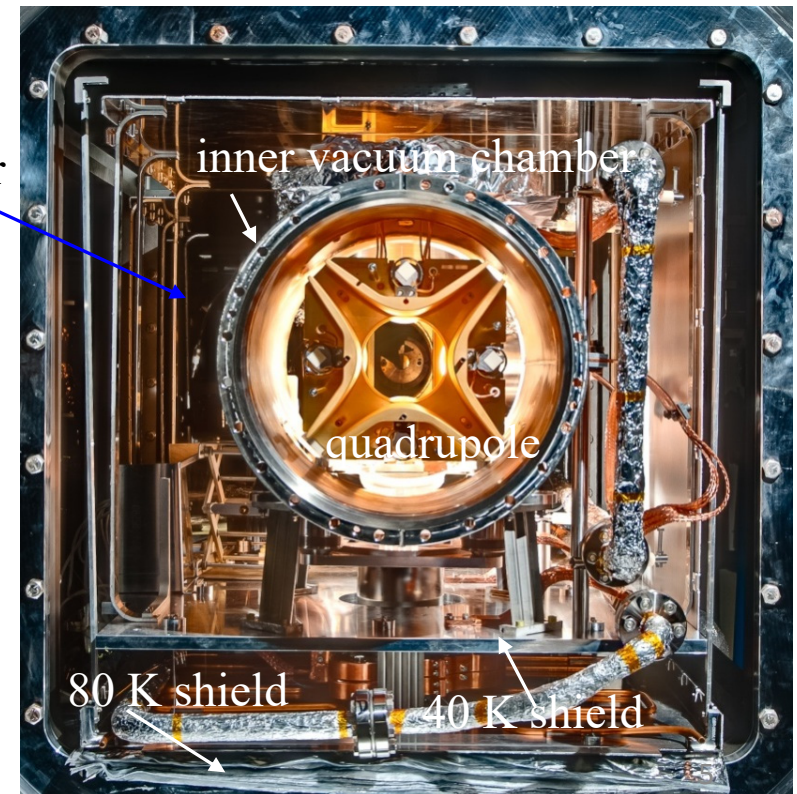
Cryogenics

- inner vacuum chamber (≤ 10 K)
cooled by superfluid He (20 W).
- isolation vacuum chamber
- 2 radiation shields (40 and 80 K)
cooled by 5-K He (600 W)
- super-insulation

isolation
vacuum
ca. 10^{-6} mbar



cryostat
isolation vacuum chamber



XHV: Extremely High Vacuum

In 300-K-operation:

250°C bake-out,
Ion-getter pumps,
NEG pump (strips),
bake-able charcoal cryo-pumps

NEG pump

cryo pump

In < 10-K-operation:

cryo adsorption at 10-K-walls,
2-K cryo condensation pumps

CSR corner

inner vacuum chamber

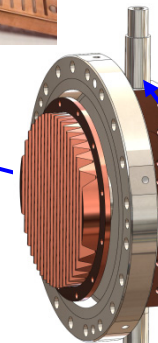
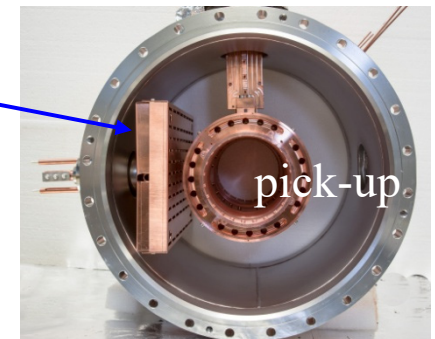
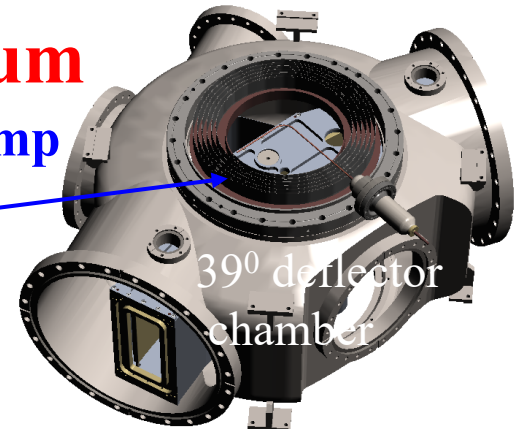
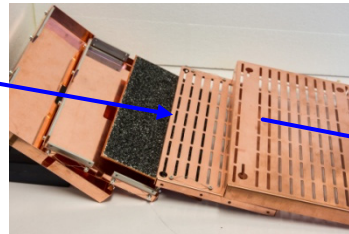
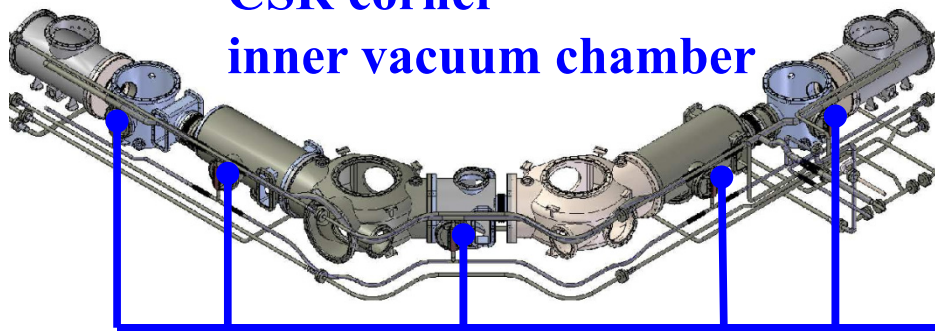
39° deflector
chamber

pick-up

He gas

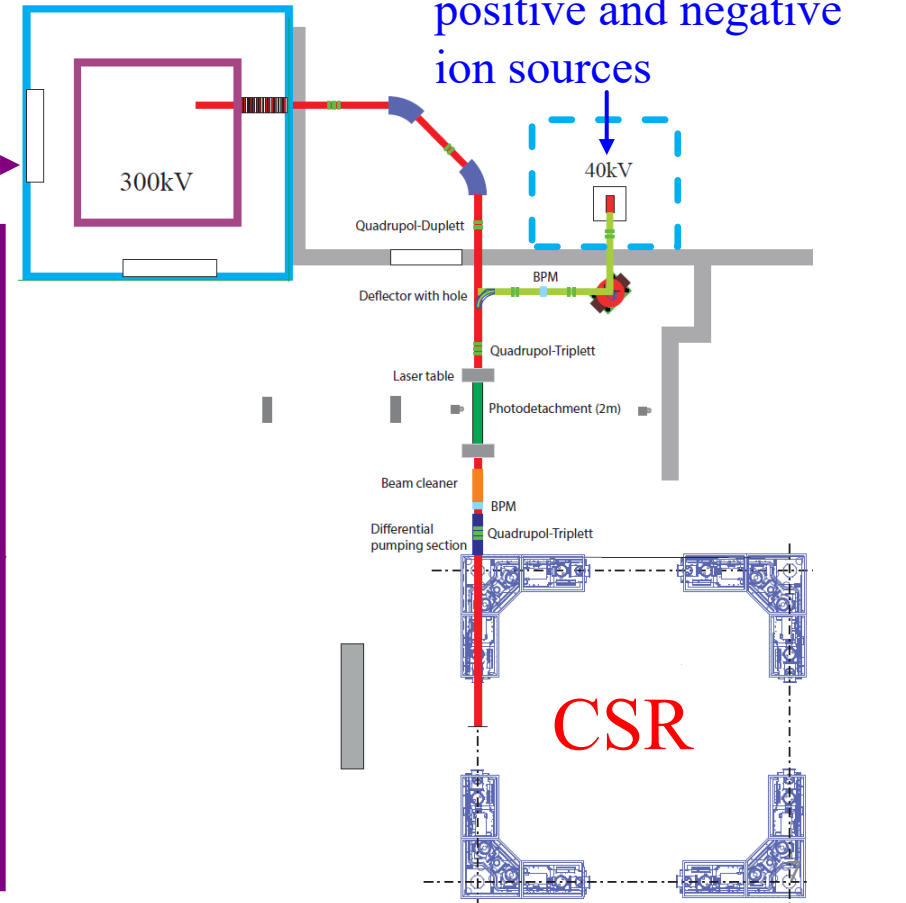
cold unit

liquid helium



High Voltage platforms

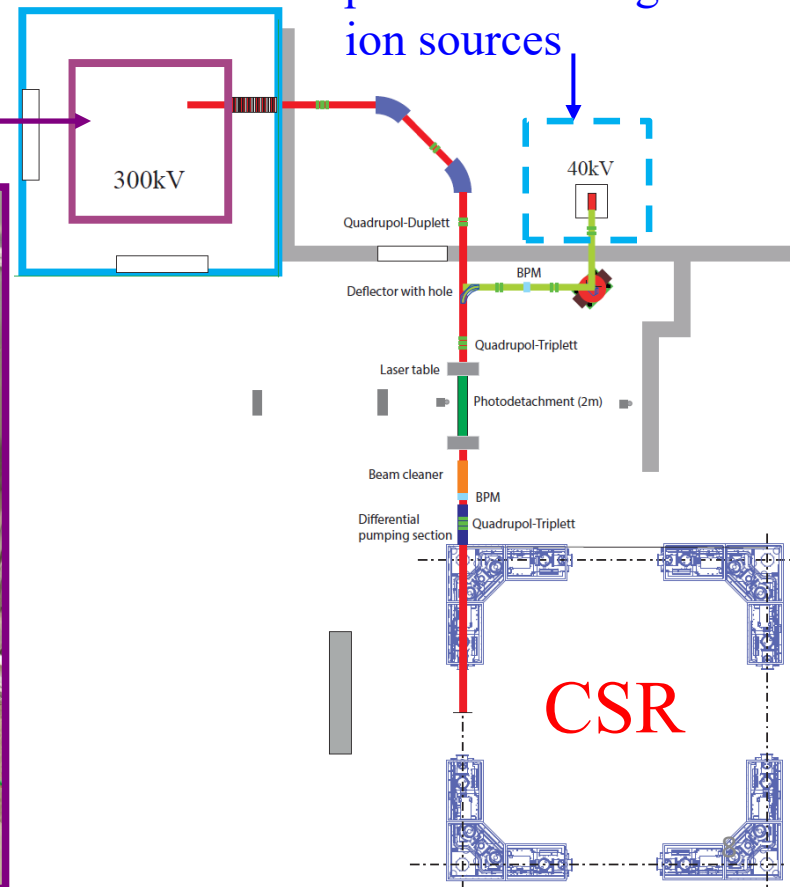
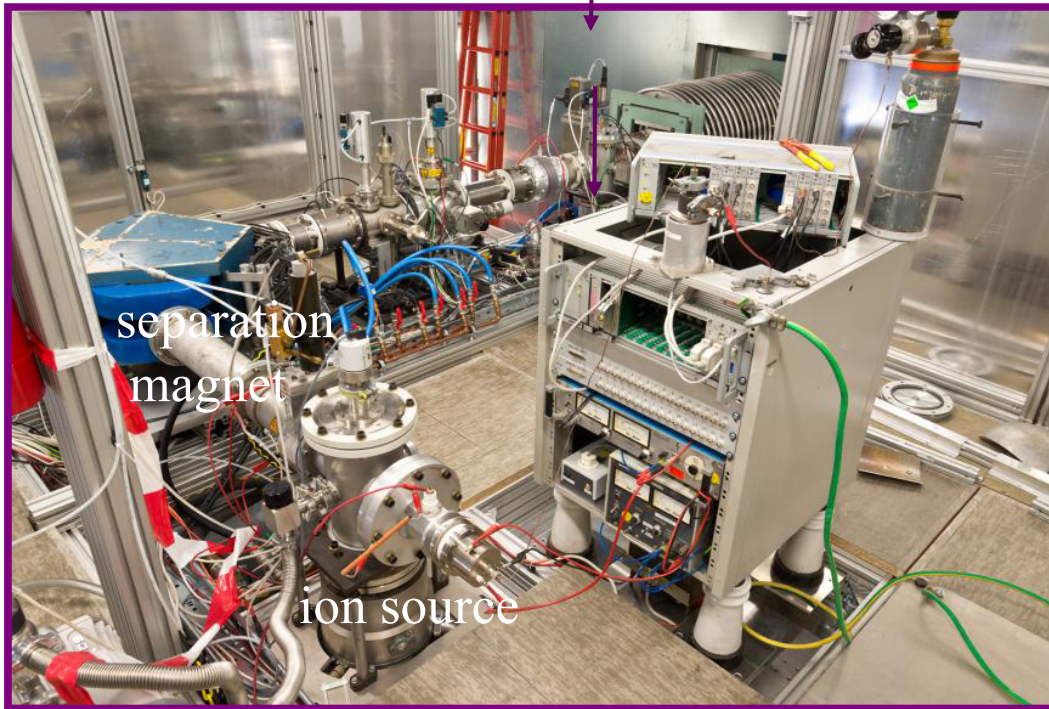
CSR main injector:
ion sources on a high
voltage platform of ± 300 kV



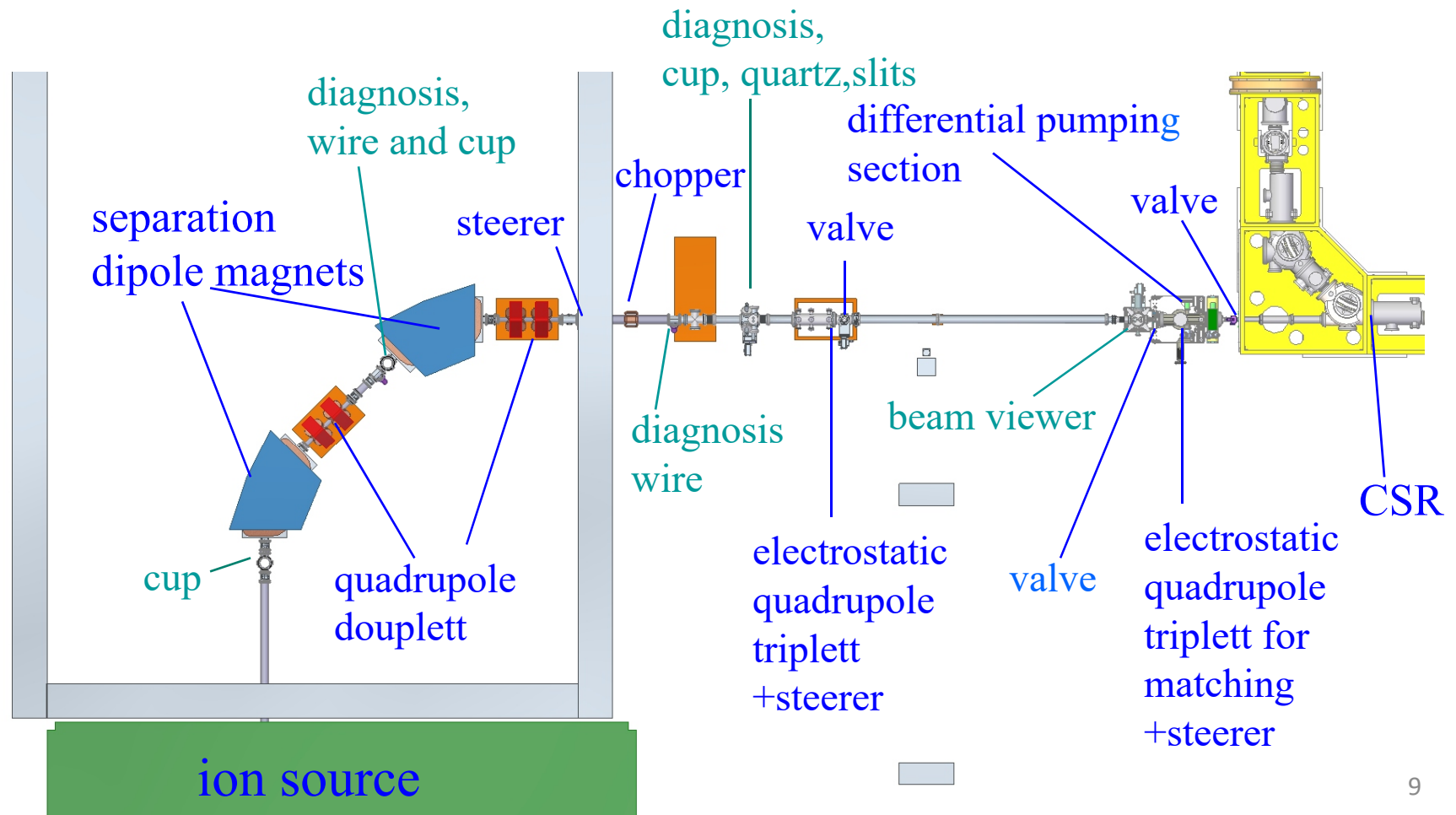
Ion sources

± 300 kV high voltage platform
positive and negative
ion sources

CSR main
injector: ± 300 kV



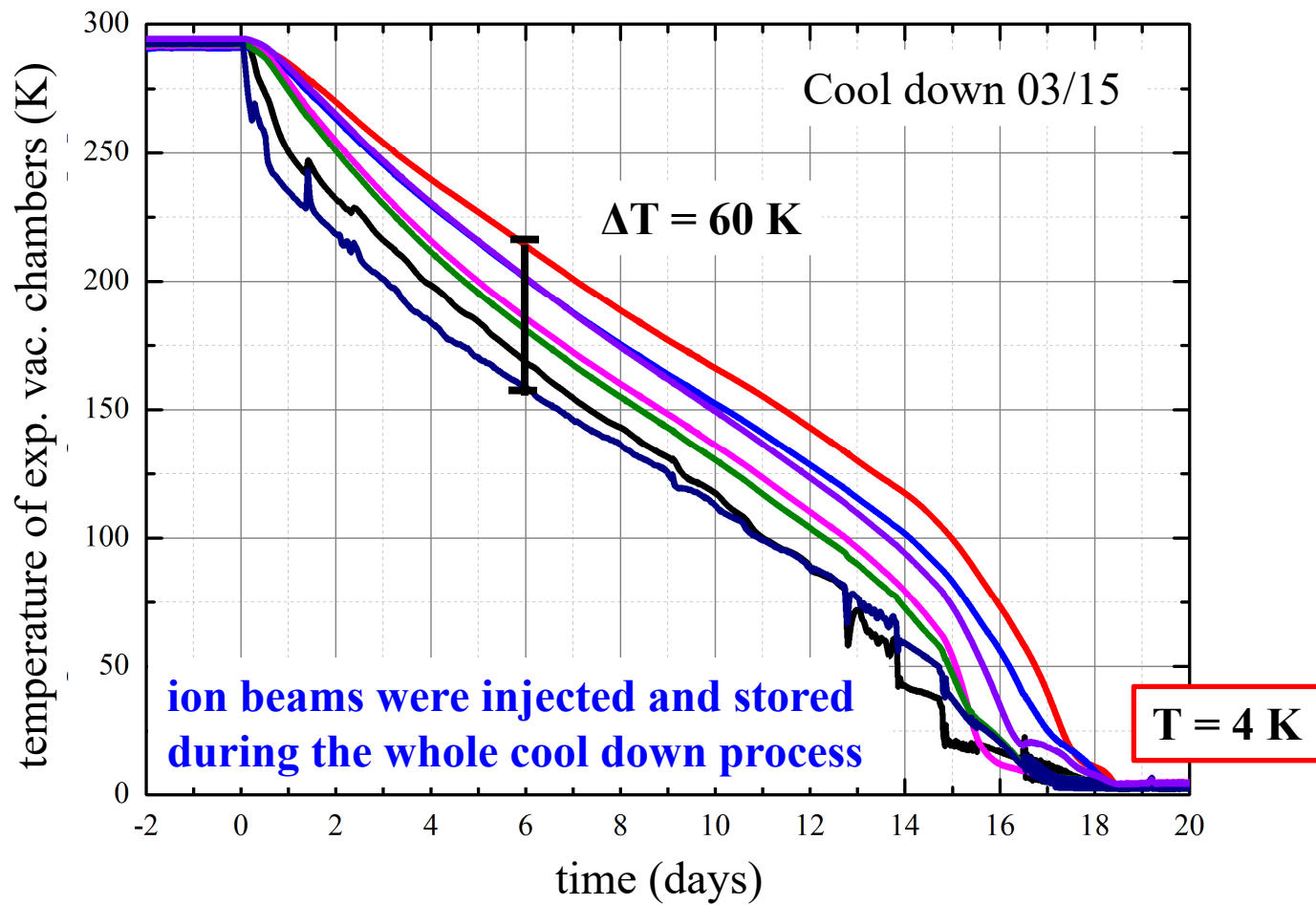
Transferline between ion source and CSR



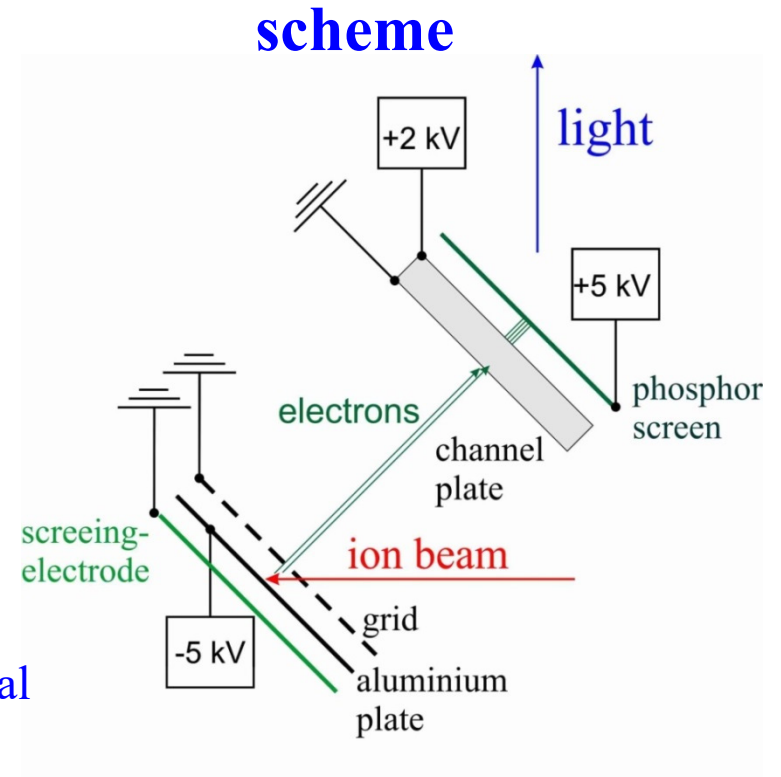
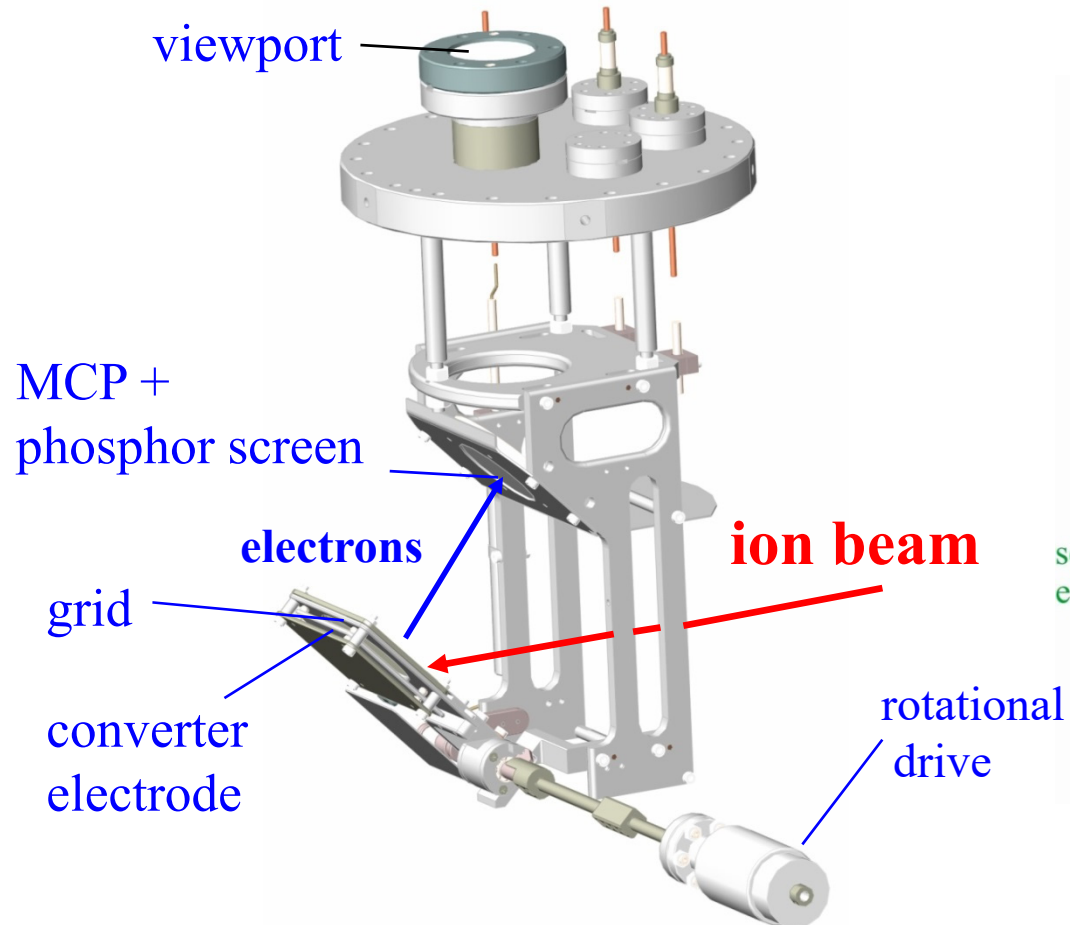
Cryogenic operation



Cool down of the CSR



Beam profiler for first turn diagnosis

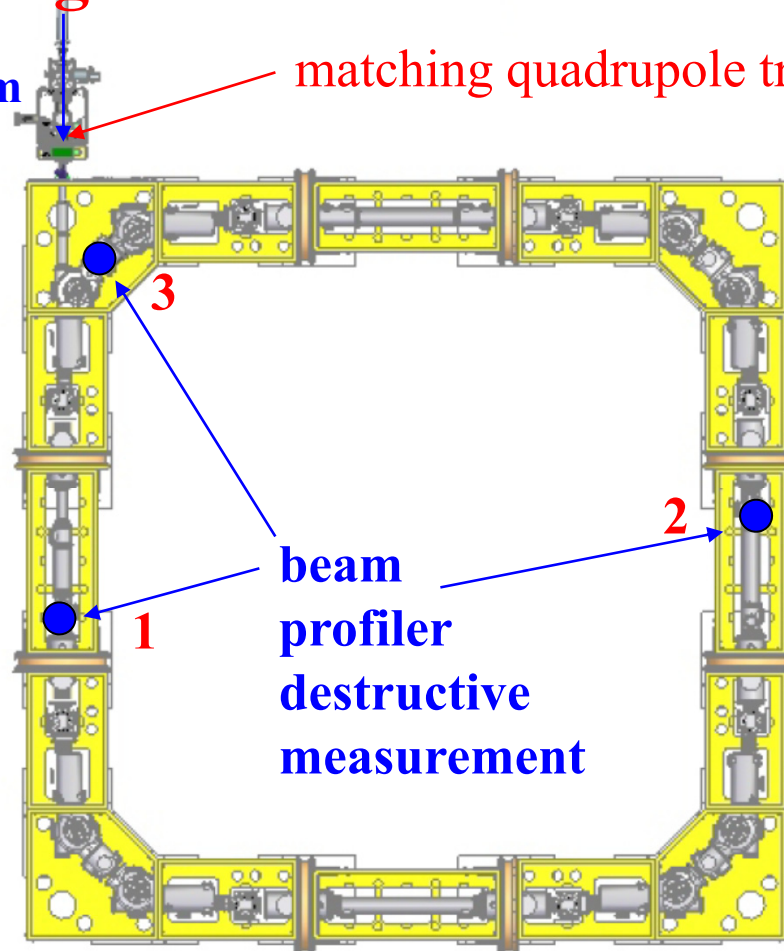


Diagnostics for ion beam injection

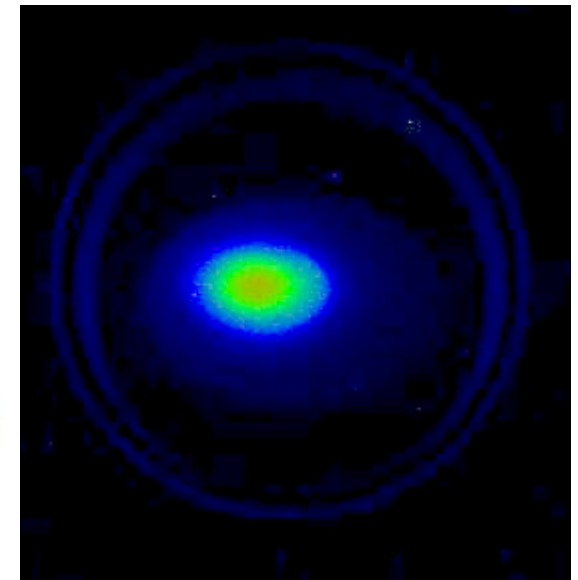
injected
ion beam

matching quadrupole triplet

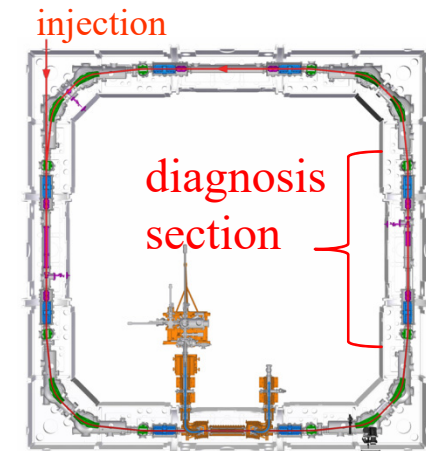
beam profiler



beam image

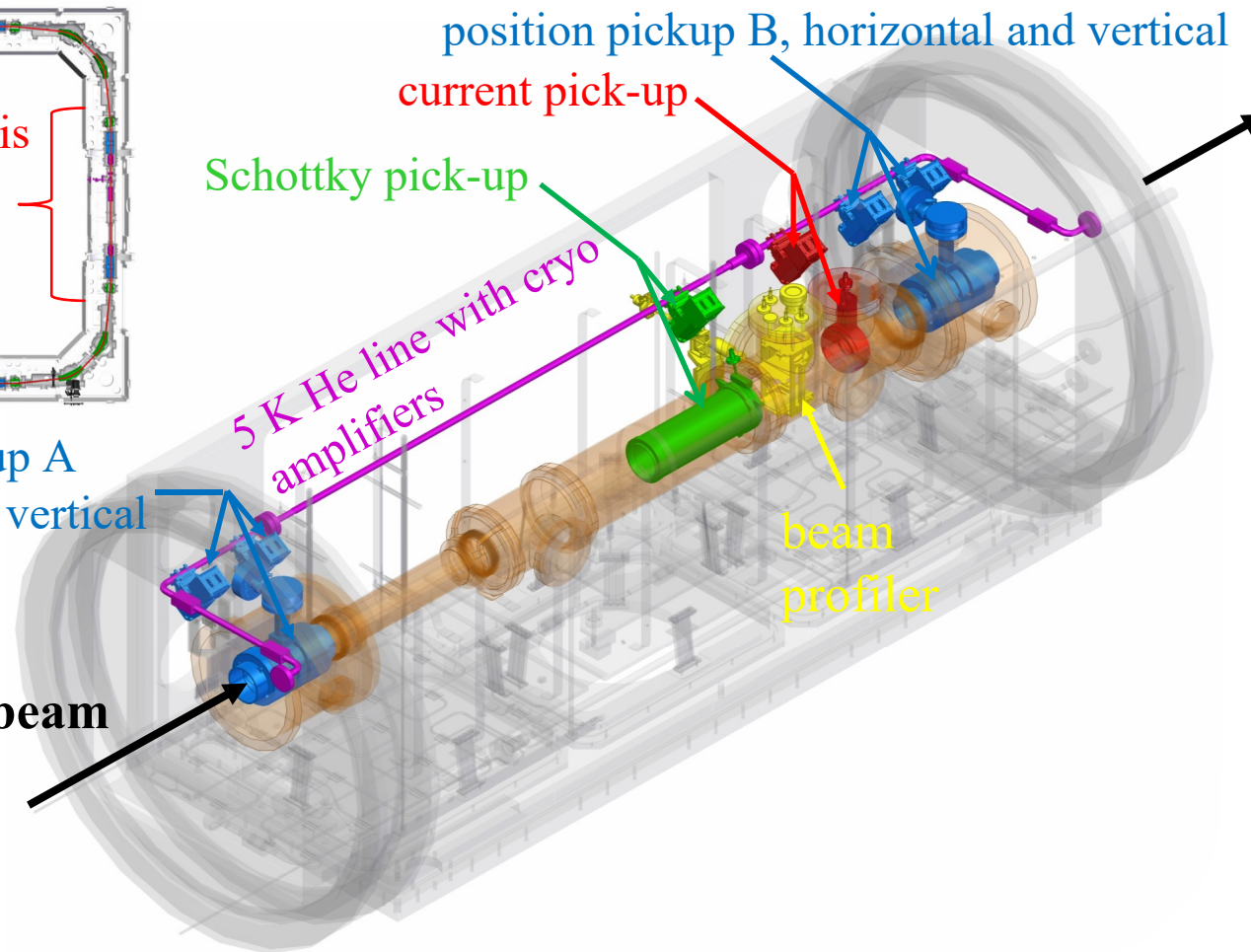


The diagnosis section

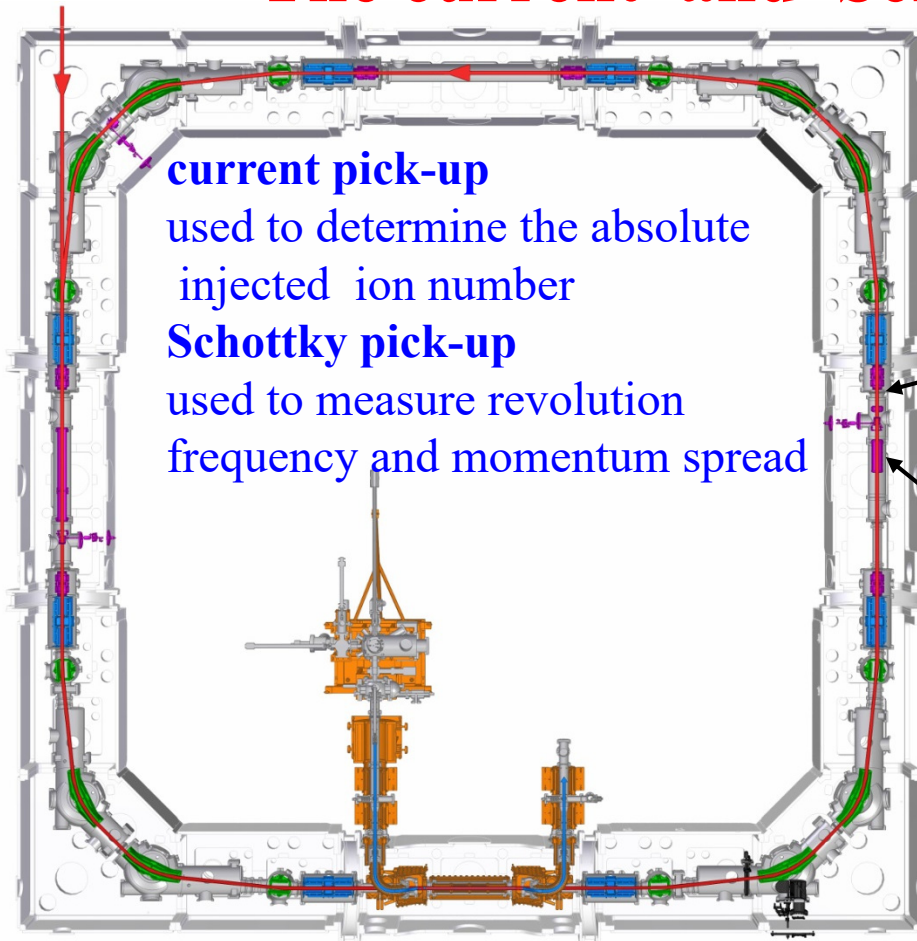


position pick-up A
horizontal and vertical

ion beam



The current and Schottky pick-up

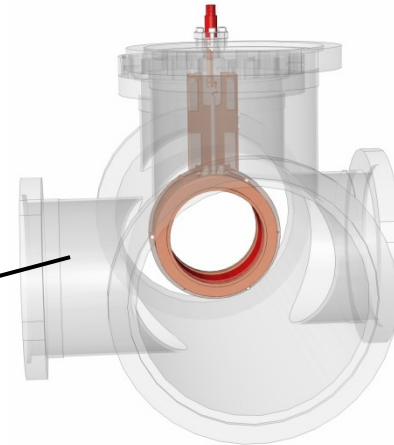


current pick-up

used to determine the absolute injected ion number

Schottky pick-up

used to measure revolution frequency and momentum spread

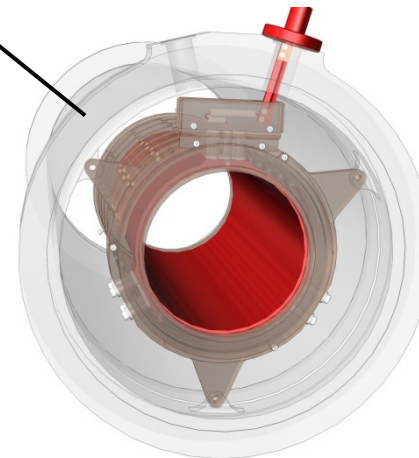


current pick-up

tube:

$L = 3.5 \text{ cm}$

$\psi = 10 \text{ cm}$



Schottky pick-up

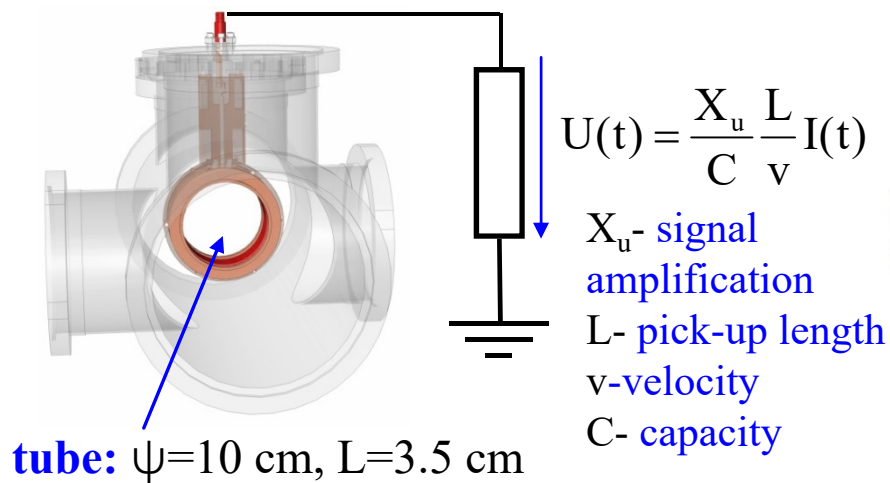
tube:

$L = 35 \text{ cm}$

$\psi = 10 \text{ cm}$

Current pick-up

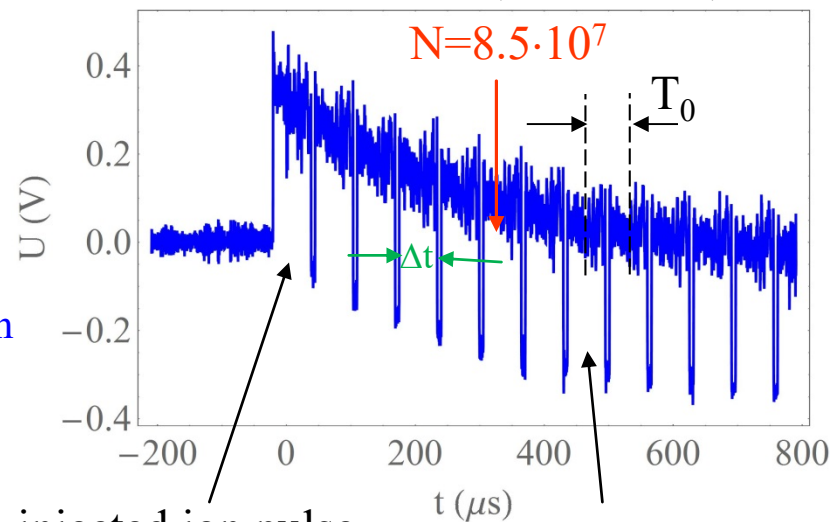
- used to measure the **absolute number** of the injected ion number (pulsed beam)
- sensitivity 10^6 singly charged ions



integration over one pulse

$$N = \frac{1}{qe} \int_{t_1}^{t_2} I(t) dt = \frac{1}{qe} \frac{Cv}{L} \int_{t_1}^{t_2} \frac{U(t)}{X_u} dt$$

measured current signal of
an $^{40}\text{Ar}^+$ ions ($E=60$ keV)



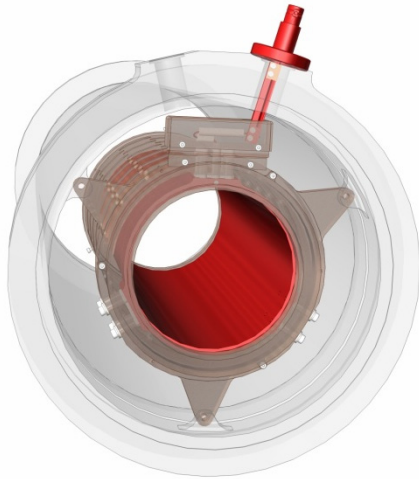
injected ion pulse

stored ion pulse

T_0 - revolution time

pulse length Δt is set up with a chopper
in front of the CSR

Schottky noise spectrum



Schottky
pick-up

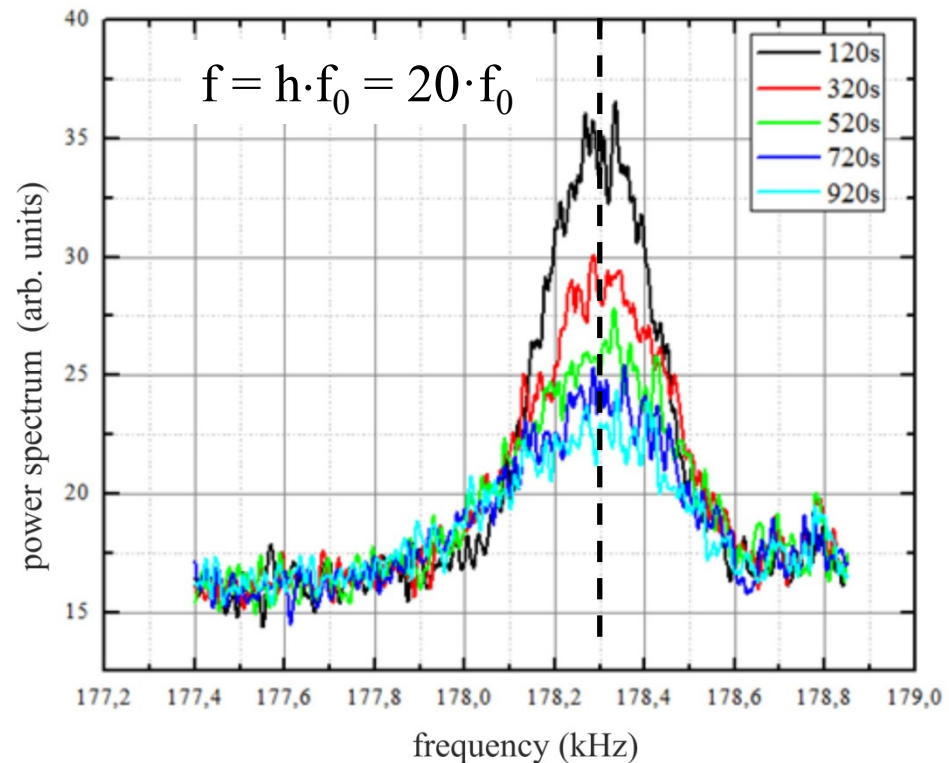
slip factor

$$\eta = \frac{\Delta f / f}{\Delta p / p}$$

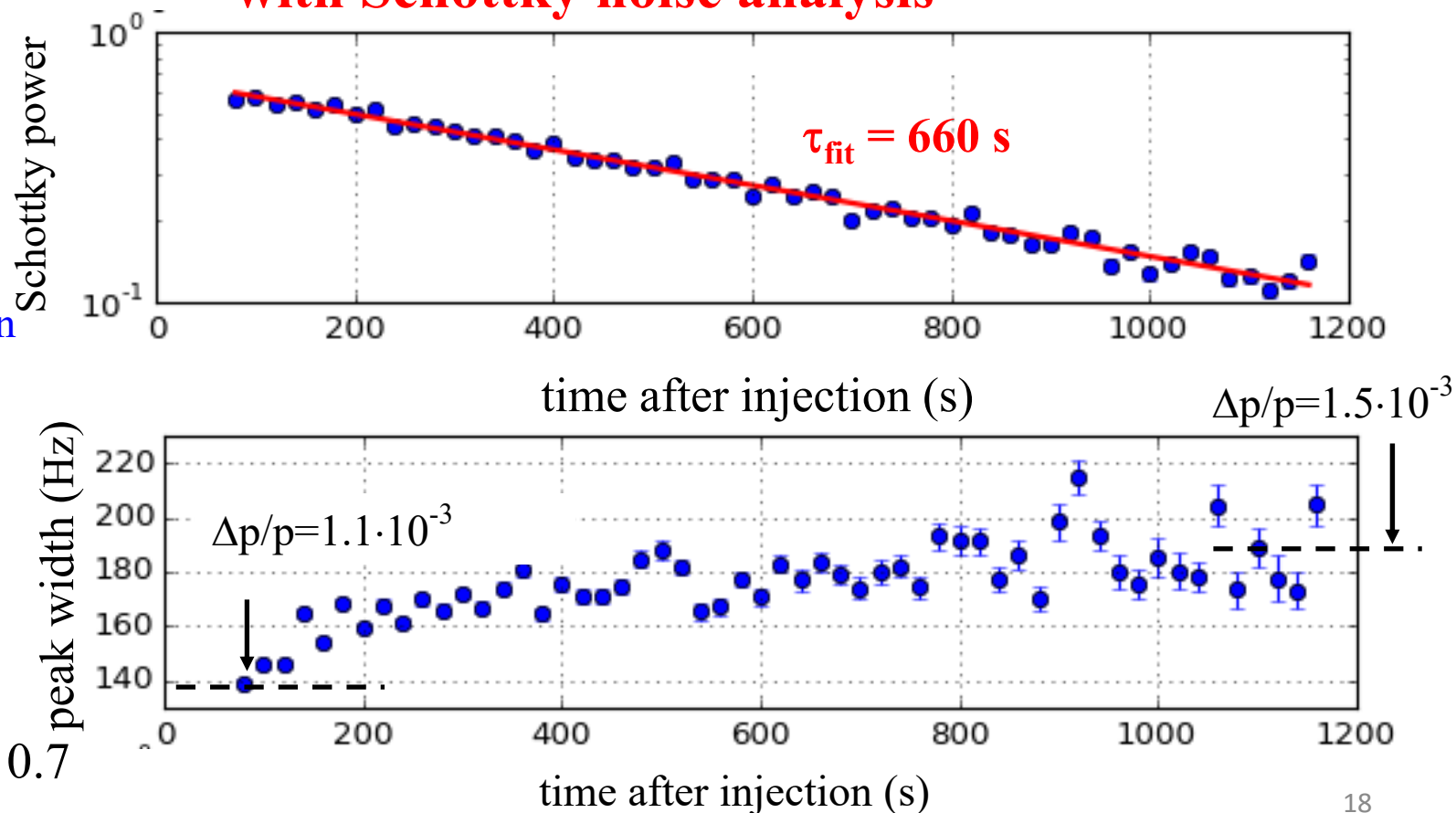
$$= 1 - \frac{1}{\gamma_{th}^2} = 0.7$$

standard mode

Time development of the Schottky noise spectrum (60 keV Co_2^- ions)



Lifetime Measurements of a stored Co_2^- beam with Schottky noise analysis



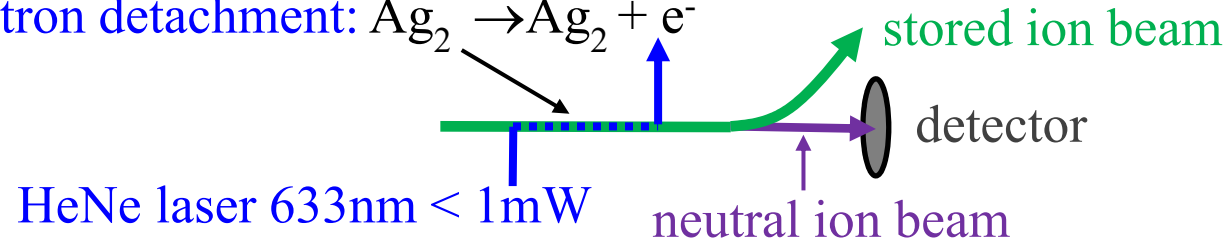
due to noise on
the electrodes
increasing
of $\Delta p/p$

$$\eta = \frac{\Delta f / f}{\Delta p / p}$$

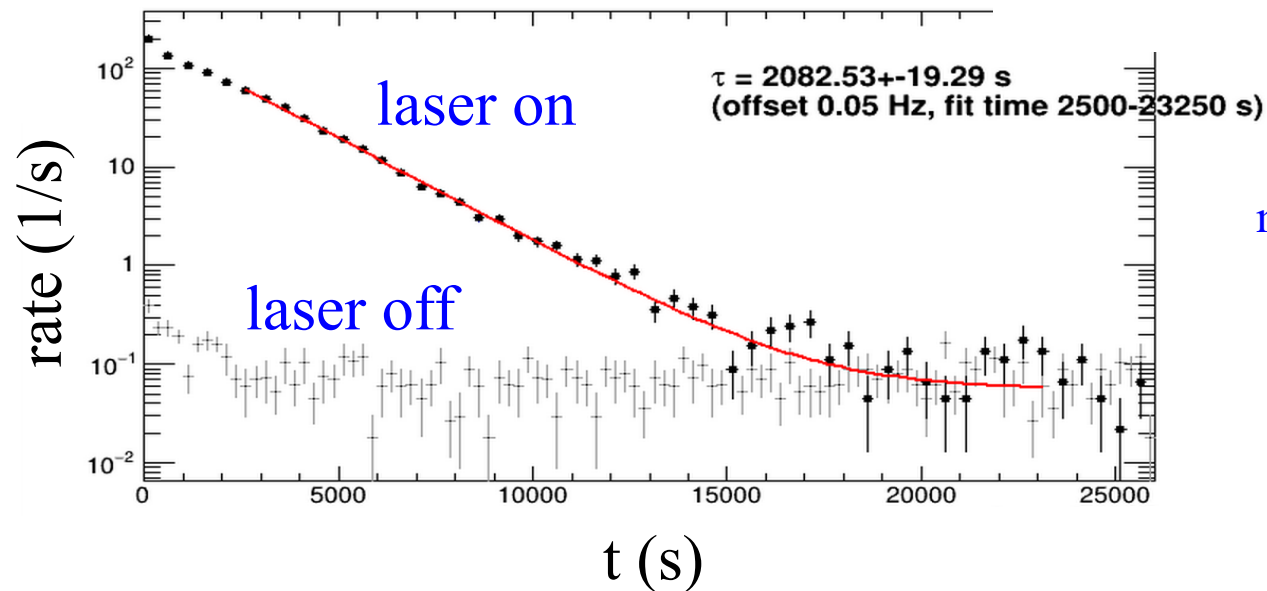
$$= 1 - \frac{1}{\gamma_{\text{th}}^2} = 0.7$$

Lifetime Measurement of stored Ag_2^- ions ($E=60$ keV)

electron detachment: $\text{Ag}_2^- \rightarrow \text{Ag}_2 + \text{e}^-$



neutral rate on the detector



measured life time:

$$\tau = 2082 \text{ s}$$

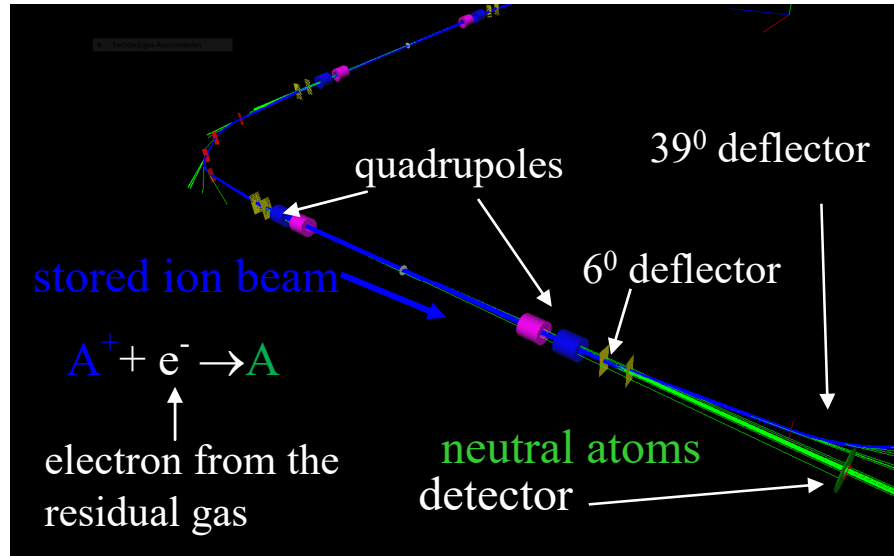
corrected for laser depletion:

$$\tau = 2500 \text{ s}$$

Measurement of the residual gas density

simulation of the neutralization process with g4beamline

simulation results



fraction of ions η_f hitting the detector

$\varepsilon_{x,90\%}$ (mm mrad)	η_f
0.5	0.126
9.1	0.119
23.0	0.118

average value $\eta_f = 0.121$

σ - cross section for neutralization

singly charged 50-60 keV ions (for H_2):

Ar^+ : $\sigma = 5.3 \cdot 10^{-16} \text{ cm}^2$ O^+ : $\sigma = 3.4 \cdot 10^{-16} \text{ cm}^2$

v - velocity

n - residual rest gas density

$R(t)$ - detector rate

$N(t)$ - number of stored particles

$$R(t) = \eta_f \cdot \frac{N(t)}{\tau_c} \quad \tau_c = \frac{1}{n \cdot v \cdot \sigma}$$

measurement:

$^{40}Ar^+$ (E=60 keV) and $N=2 \cdot 10^8$:

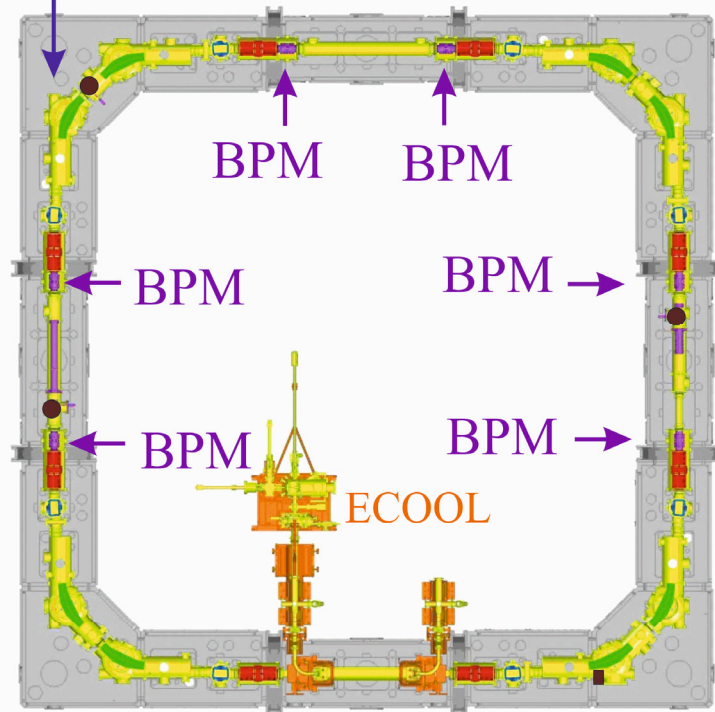
$R < 10 \text{ 1/s} \Rightarrow n < 20 \text{ H}_2 \text{ molecules/cm}^3 \text{ !!!}$

$\Rightarrow$ vacuum life time: $\tau_v > 10^6 \text{ s} \approx 280 \text{ h} \Rightarrow$ lifetime is not residual gas dependent !!!

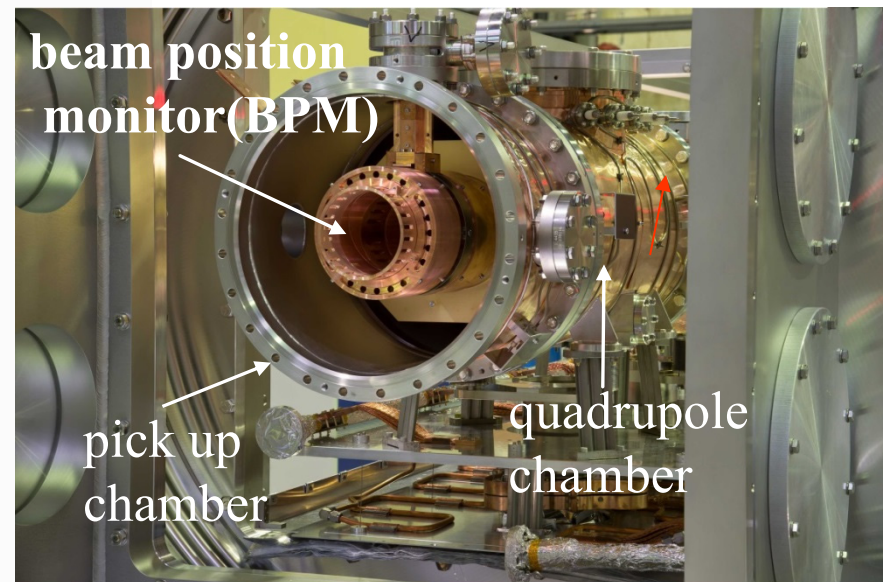
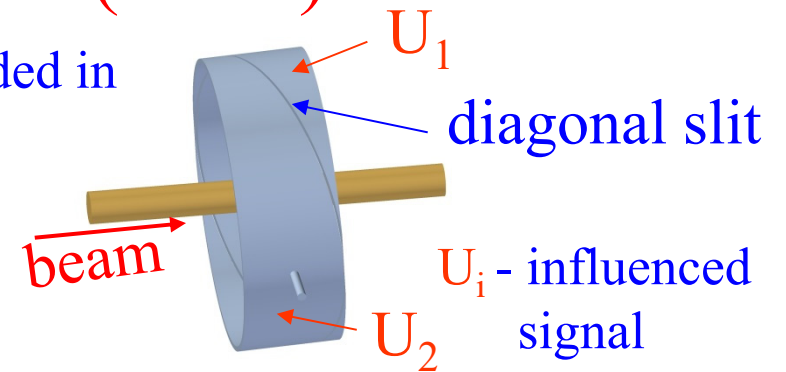
Beam Position Monitor (BPM)

CSR has 6 horizontal and 6 vertical position pick ups (BPM)

injection



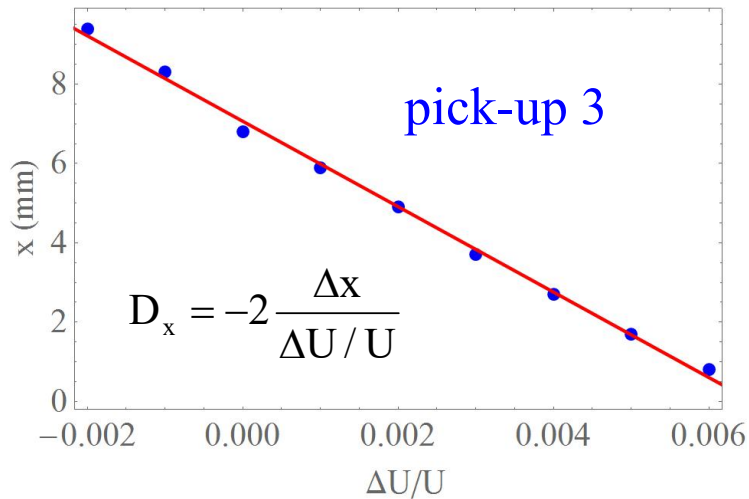
tube divided in two parts



Dispersion in the straight section

pick-up measurements

closed orbit change x via
variation of all potentials by $\Delta U/U$



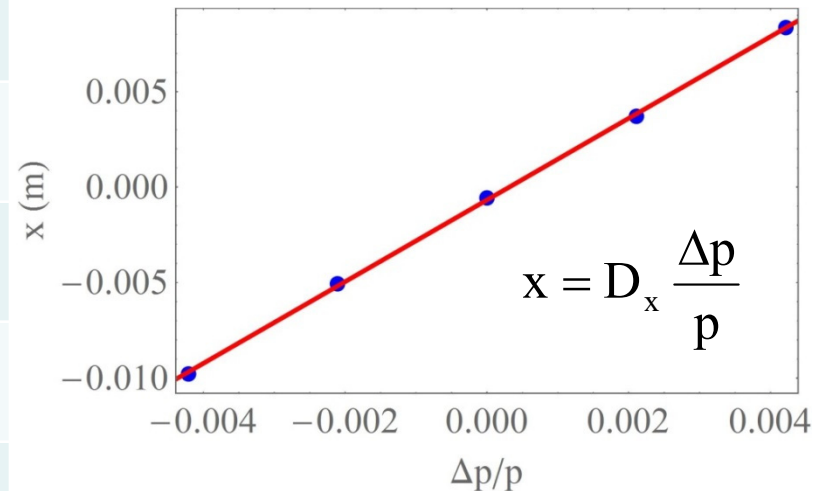
average value

$$\overline{D}_x = 2.17 \text{ m}$$

pick-up	D_x (m)
1	2.19
2	2.23
3	2.15
4	2.17
5	2.16
6	2.09

g4beamline simulation

tracking of particles with different
momenta and plotting the closed
orbit position x as a function of $\Delta p/p$



$$D_x = 2.14 \text{ m}$$

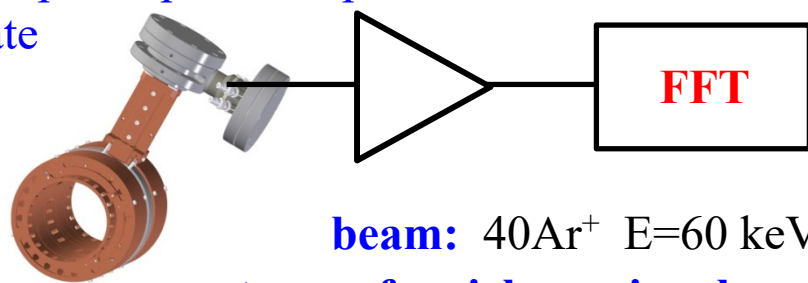
remark: $D_x = 2.14 \text{ m}$ is the maximum
dispersion in the standard mode

Application of pick-up measurements

determination of the horizontal and vertical tune

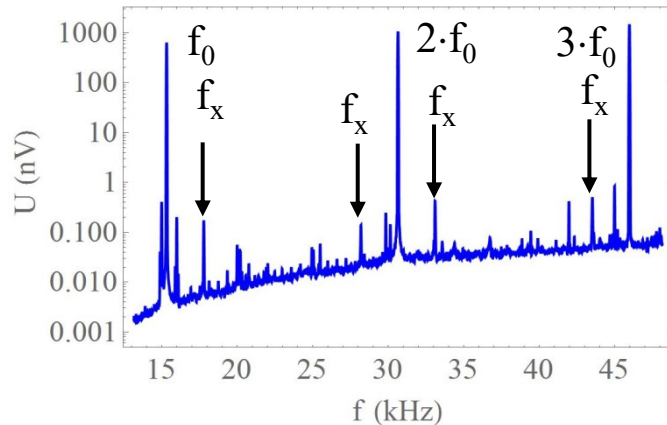
one pick-up
plate

amplification



beam: 40Ar^+ $E=60\text{ keV}$

spectrum of a pick-up signal
induced on a horizontal plate



f_0 - revolution frequency

f_x - betatron side band

$$f_x = f_0 (n \pm q_x)$$

n - integer number

q_x - non integer part of the tune

effective quadrupole length

The effective quadrupole length are determine by matching the measured tunes with the calculated tunes.

result:

calculated with **TOSCA**: $l_{\text{eff}}=0.211\text{ m}$

measurement:

quadrupole family 1: $l_{\text{eff}}=0.208\text{ m}$

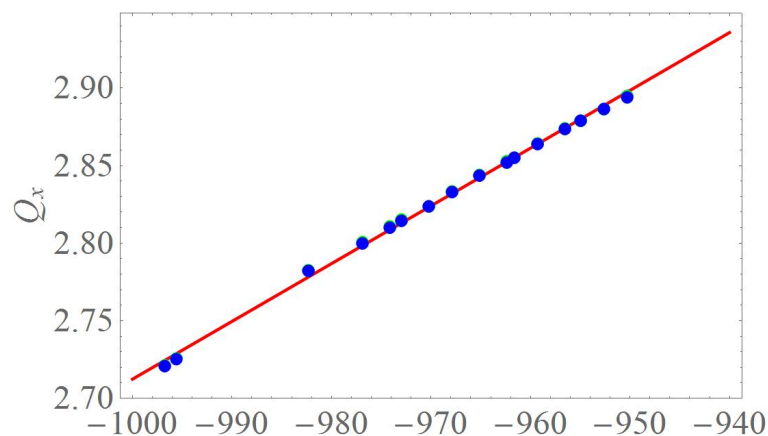
quadrupole family 2: $l_{\text{eff}}=0.209\text{ m}$ ₂₃

Determination of horizontal β_x and vertical β_y functions

$$\Delta Q_x = \frac{1}{4\pi} \int \beta_x(s) \cdot \Delta K(s) ds$$

$$\Rightarrow \bar{\beta}_x = \frac{\pi}{2} \frac{1}{\alpha} \frac{\Delta Q_x}{\Delta U} \frac{1}{L_m} \text{ with } \alpha = \frac{K}{U}$$

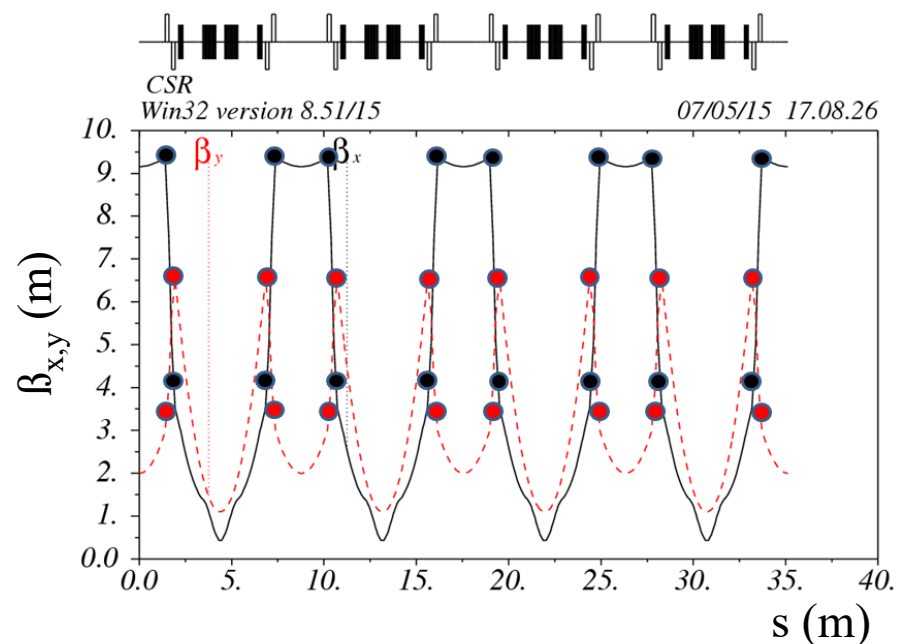
horizontal tune as a function of voltage of quadrupole family 2



Q_x - horizontal tune U_2 (V)

U_2 -voltage of quadrupole family 2

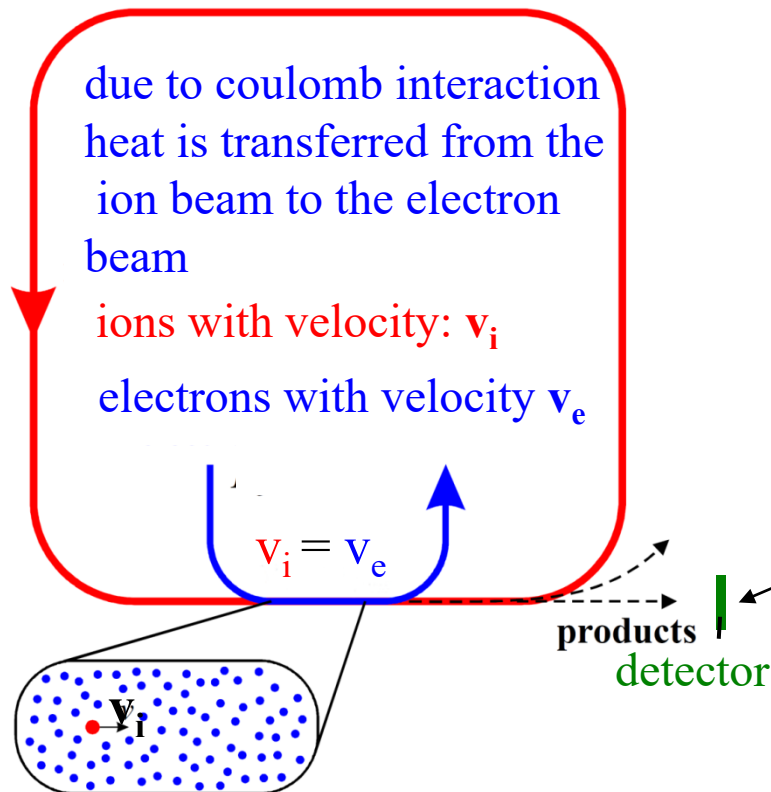
MAD calculation of horizontal and vertical β function (standard mode)



- measured horizontal β_x function
- measured vertical β_y function

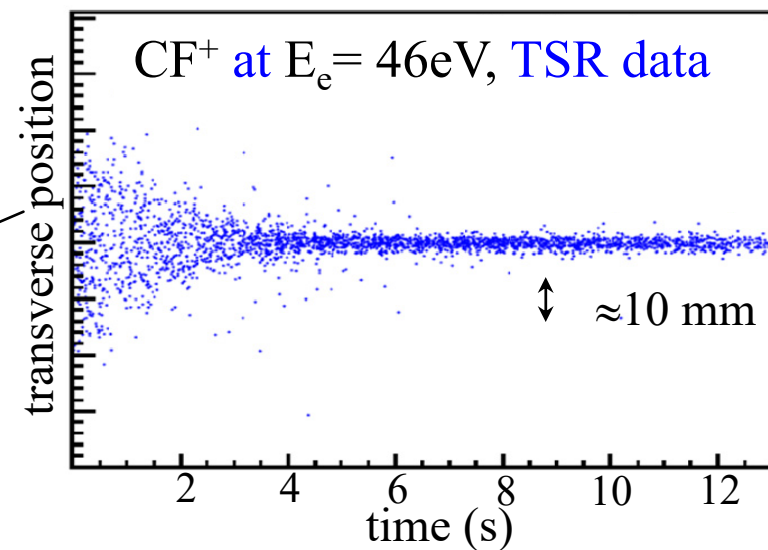
CSR electron cooler – principle

principle of electron cooling:

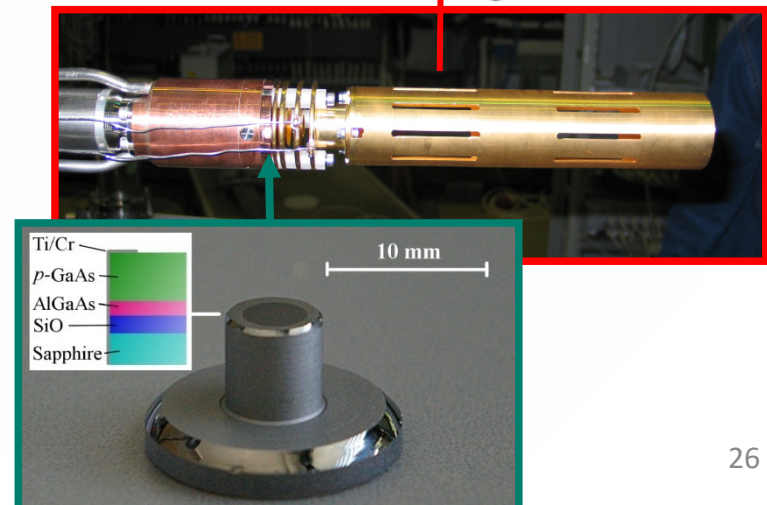
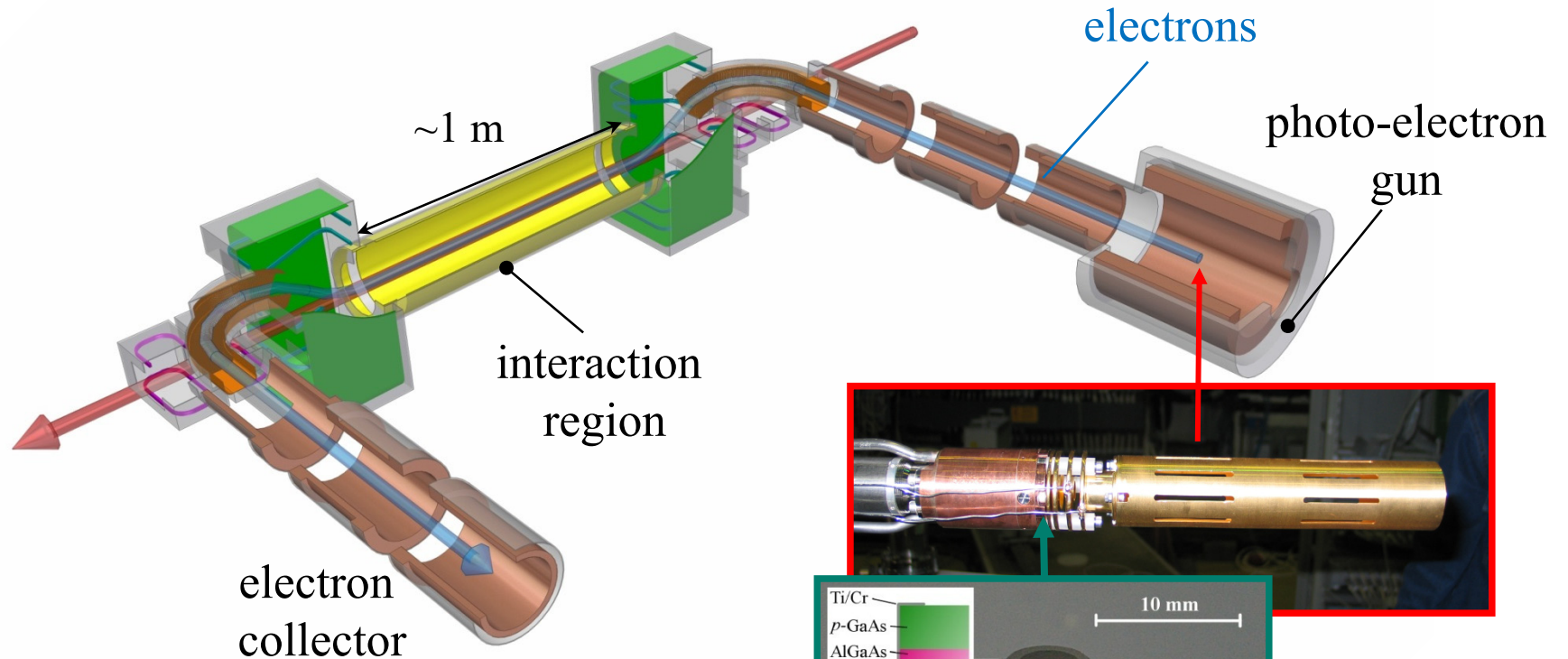


E_e (eV)	ion
163	for 300 keV p^+
~ 10	for most ions
1	for $M_{ion} = 160$ u

electron cooling experiment at the TSR

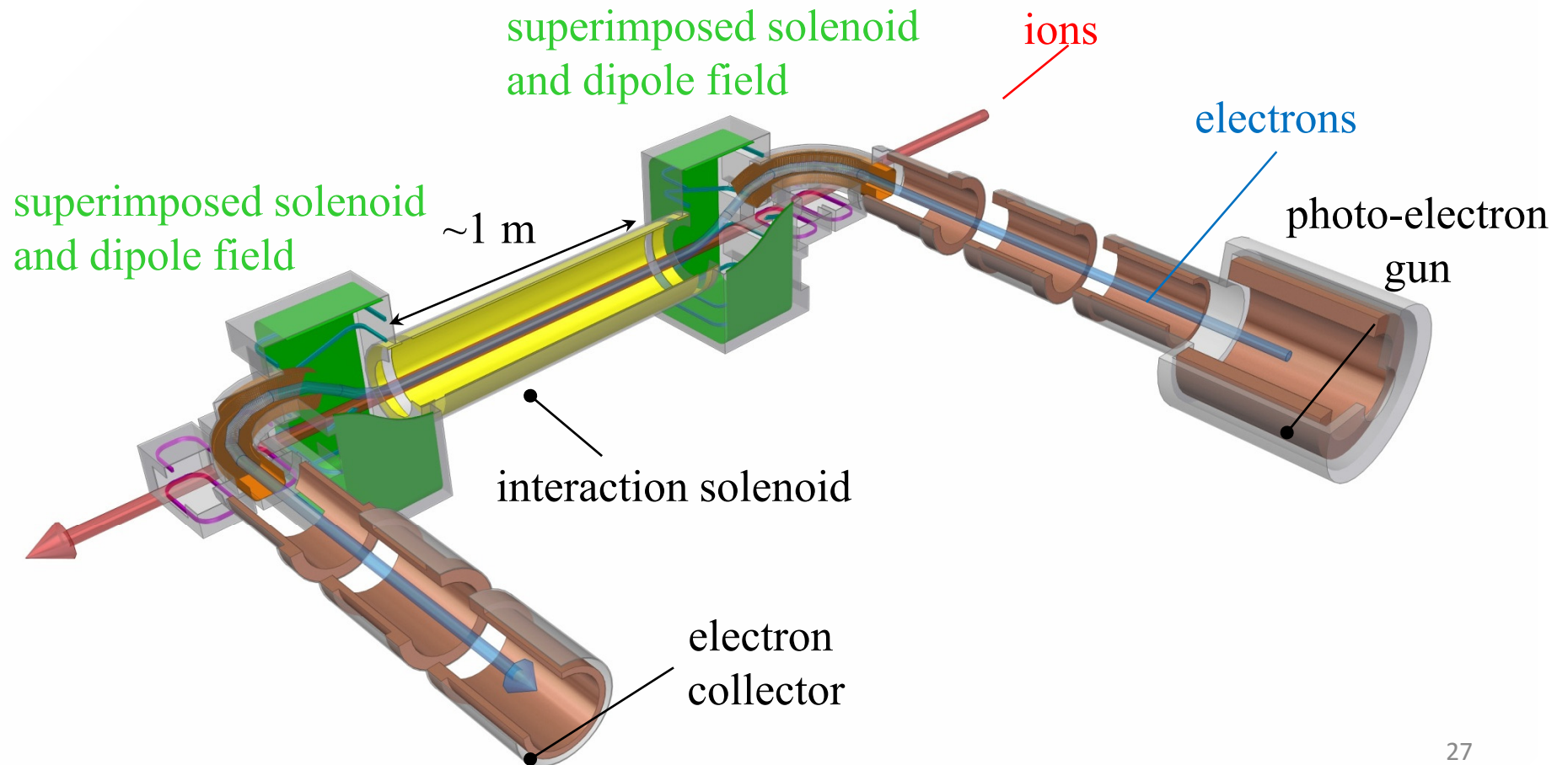


CSR electron cooler – photo-cathode



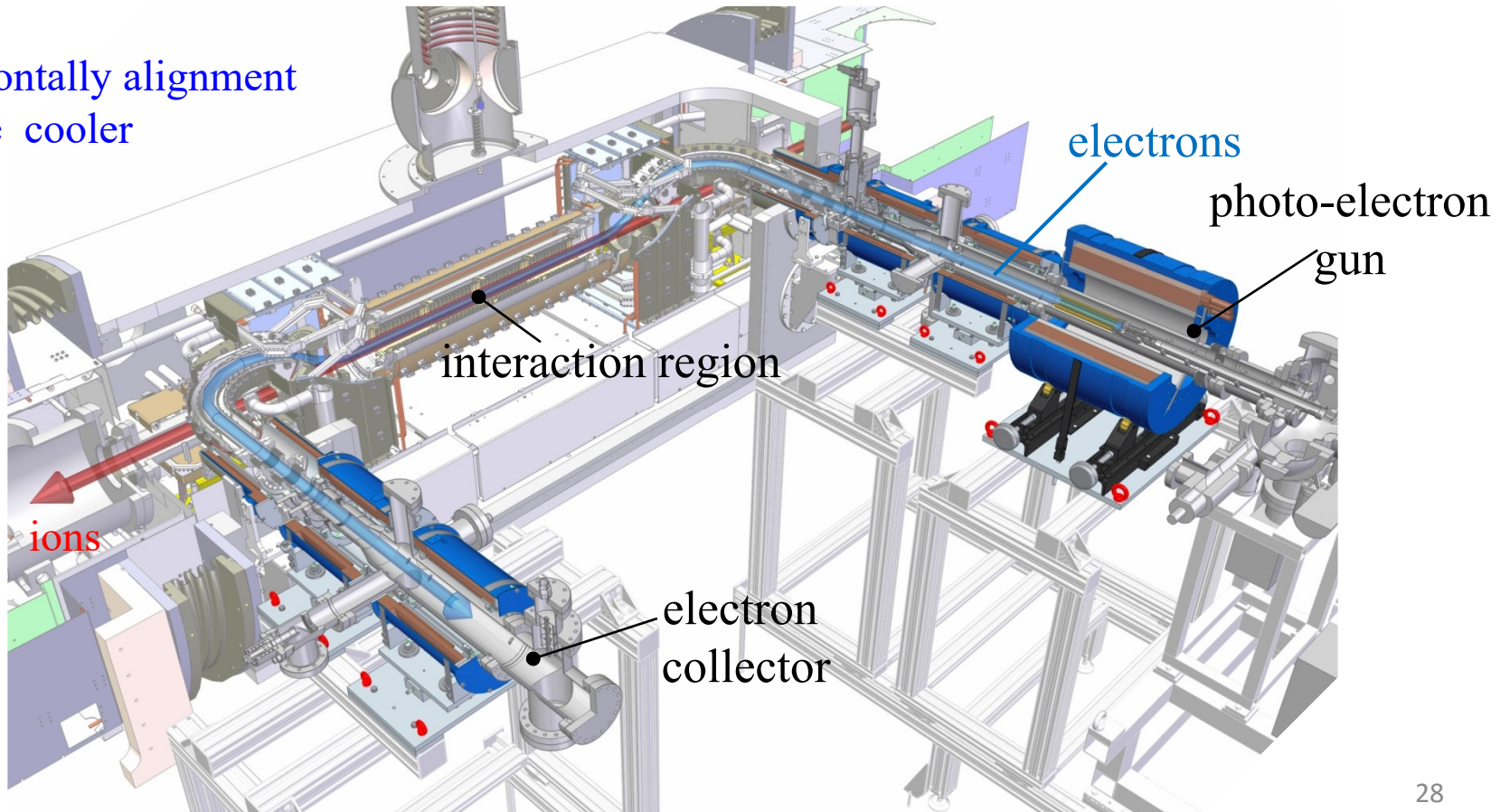
Shornikov et al., Phys. Rev. ST AB **17**, 042802 (2014)

CSR electron cooler – magnetic guiding field

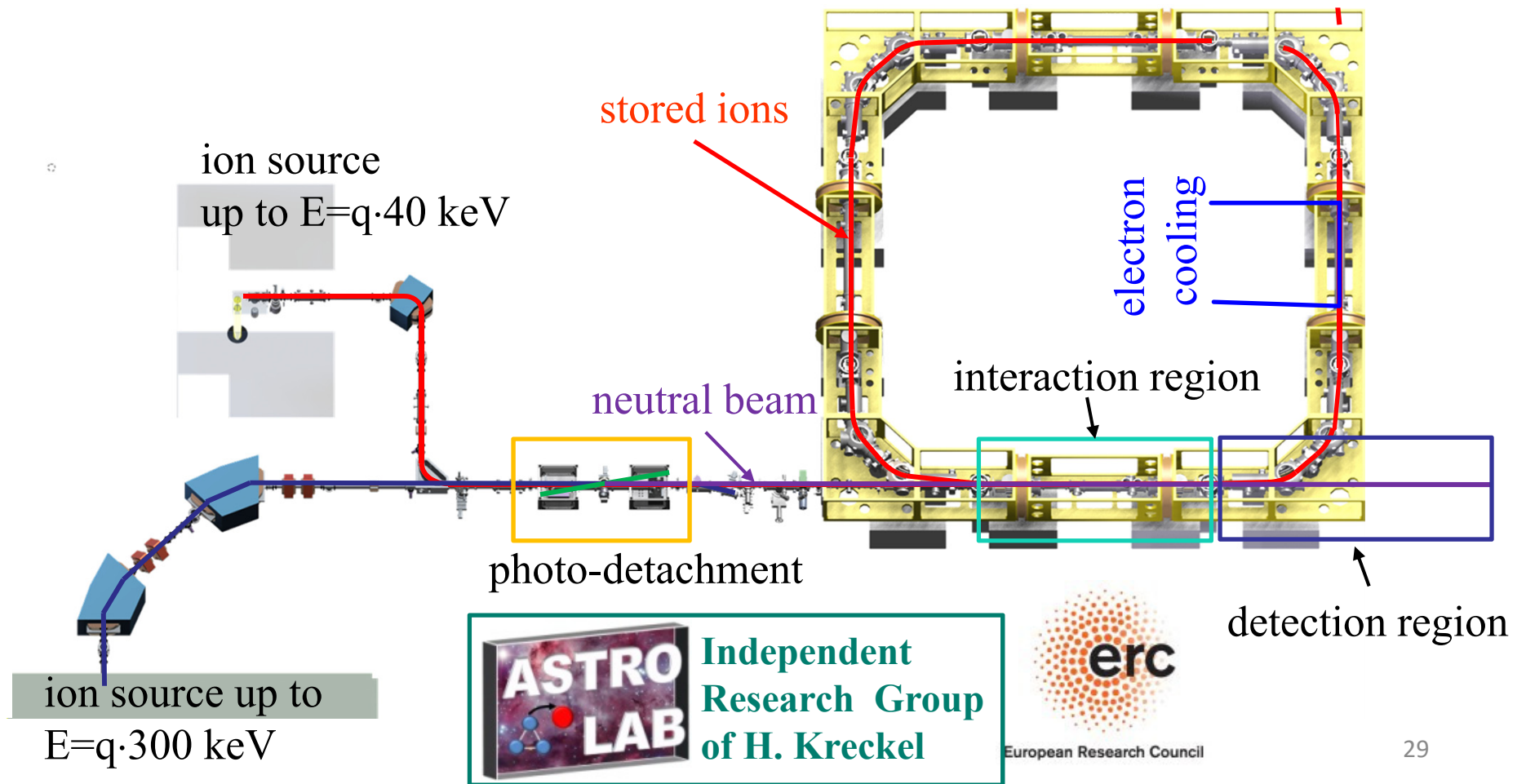


CSR electron cooler – Design

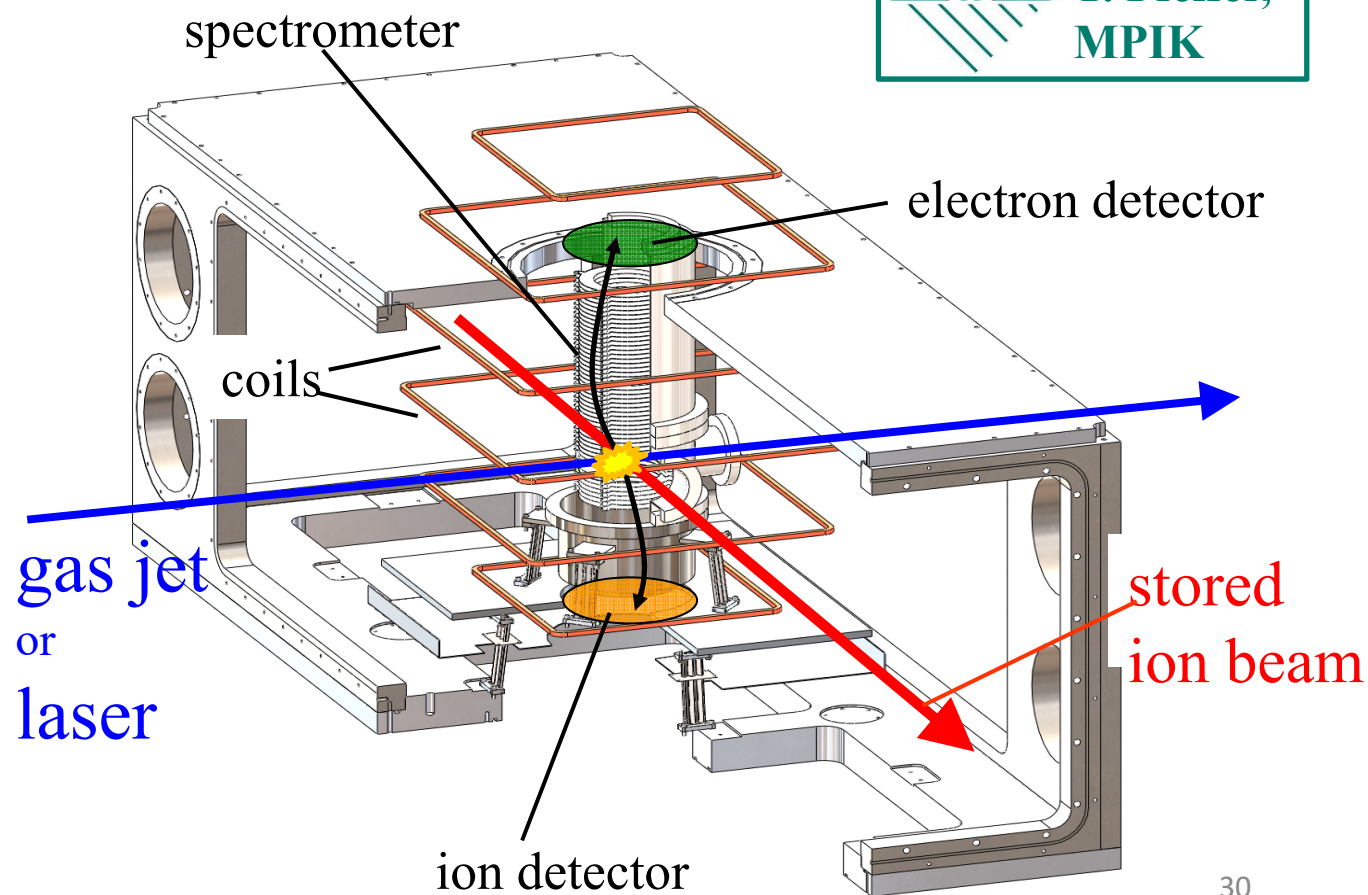
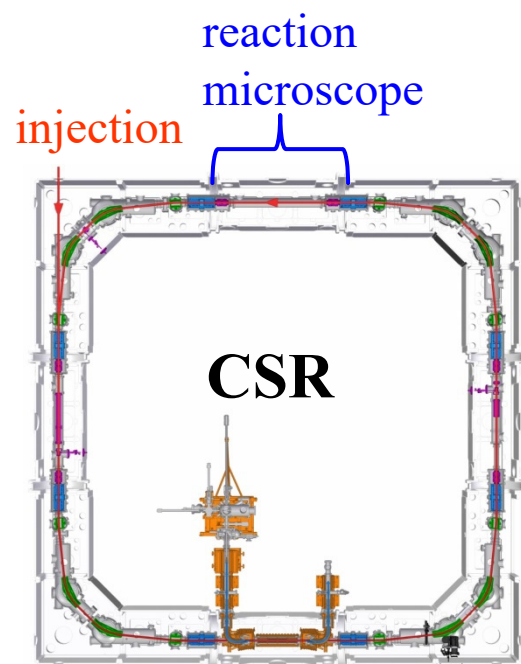
horizontally alignment
of the cooler



Neutral beam experiment



The reaction microscope



Thanks for your attention!



A. Becker

K. Blaum

C. Breitenfeldt

F. Fellenberger

S. George

J. Göck

M. Grieser

F. Grussie

R. von Hahn

P. Herwig

J. Karthein

C. Krantz

H. Kreckel

S. Kumar S.

M. Lange

J. Lion

S. Lohmann

C. Meyer

P. M. Mishra

O. Novotný

P. O'Connor

R. Repnow

S. Saurabh

S. Schippers

C. D. Schröter

D. Schwalm

L. Schweikhard

K. Spruck

X. Urbain

S. Vogel

A. Wolf

D. Zajfman

